

**Search Notes**

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Examiner

Le Nguyen

Applicant(s)/Patent under  
Reexamination

VRONAY ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
715	828	6/14/2007	LVN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
US-PGPub, USPAT: 715/828		6/14/2007	LVN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR